

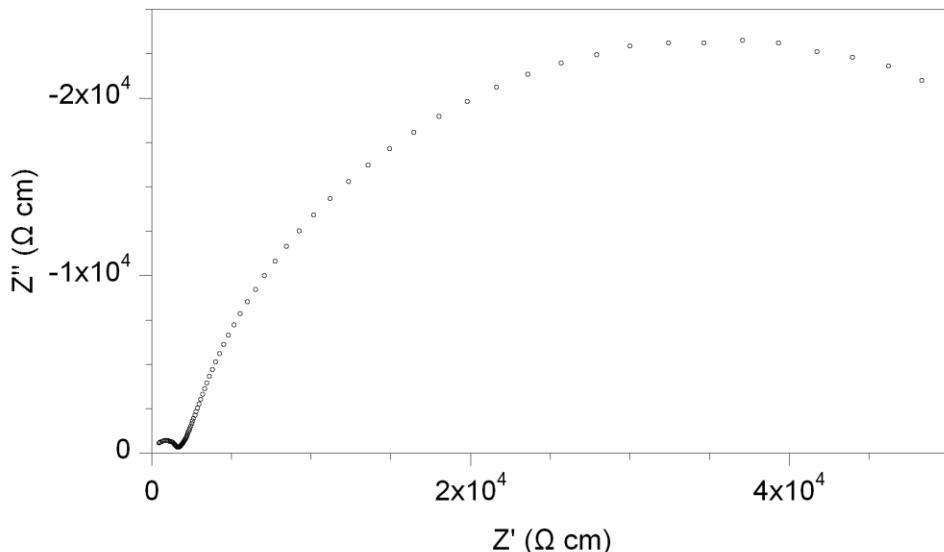
## **Synthesis and characterization of proton conducting oxyanion doped Ba<sub>2</sub>Sc<sub>2</sub>O<sub>5</sub>**

### **Supplementary data**

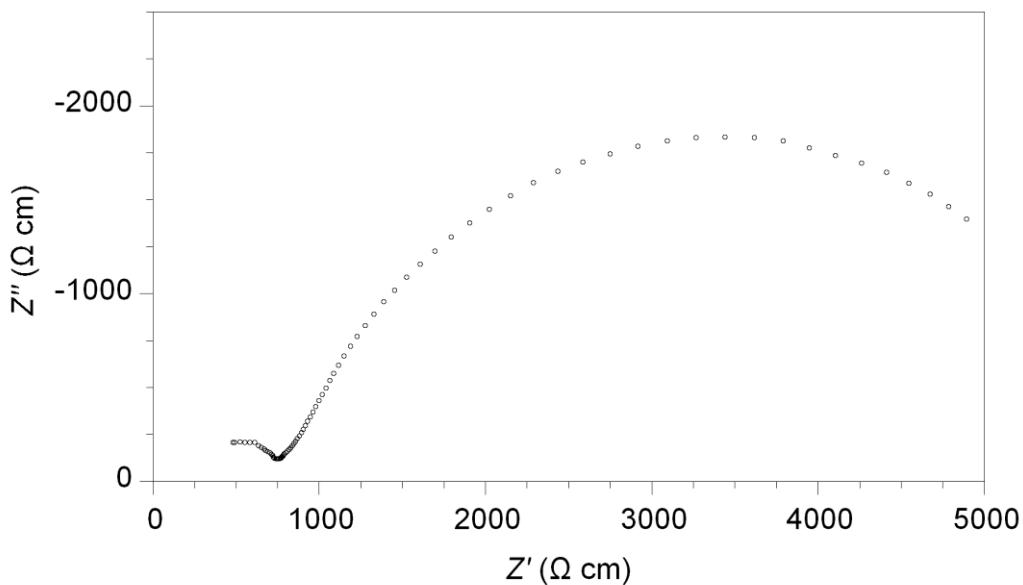
#### **Impedance Data**

Fig 1. Impedance spectra for Ba<sub>2</sub>Sc<sub>1.6</sub>P<sub>0.4</sub>O<sub>5.4</sub> in dry N<sub>2</sub> at (a) 300 °C, (b) 380 °C showing typical bulk and grain boundary semicircles

(a)



(b)



### **Structure refinements using X-ray diffraction data**

Fig. 2 Observed (cross), calculated (line), reflection positions and difference plots (observed – calculated) of  $\text{Ba}_2\text{Sc}_{1.6}\text{P}_{0.4}\text{O}_{5.4}$  from the Rietveld refinement for room temperature X-ray diffraction data.

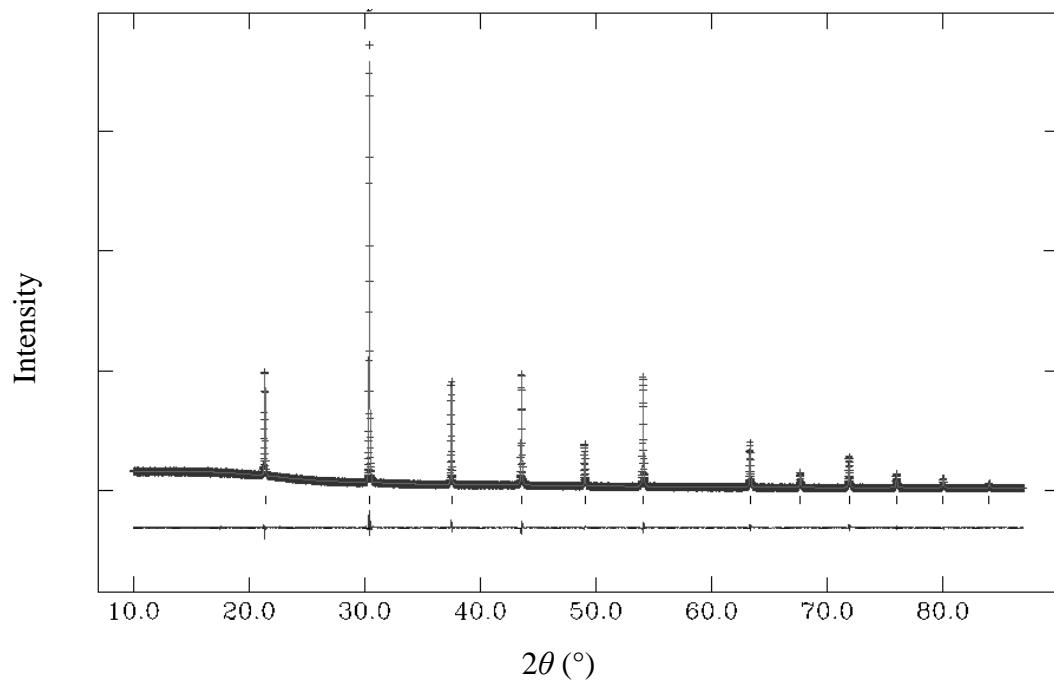


Table 1 Refined crystal structure of  $\text{Ba}_2\text{Sc}_{1.6}\text{P}_{0.4}\text{O}_{5.4}$  using cubic  $Pm\bar{3}m$  (221) space group using room temperature X-ray diffraction data.

		$a$ (Å)	$R_{wp}$	$R_p$	$\chi^2$	
		4.1504 (1)	5.15	3.70	1.83	
		$x$	$y$	$z$	Fractional occupancy	
					$U_{iso}$ (Å $^2$ x 100)	
Ba	1(b)	$\frac{1}{2}$	$\frac{1}{2}$	$\frac{1}{2}$	1.00	2.22 (2)
Sc	1(a)	0	0	0	0.794 (8)	2.67 (6)
P	1(a)	0	0	0	0.206 (8)	2.67 (6)
O	3(d)	0	0	$\frac{1}{2}$	0.896 (5)	3.6 (1)

Fig. 3 Observed (cross), calculated (line), reflection positions and difference plots (observed – calculated) of  $\text{Ba}_2\text{Sc}_{1.5}\text{P}_{0.5}\text{O}_{5.5}$  from the Rietveld refinement for room temperature X-ray diffraction data.

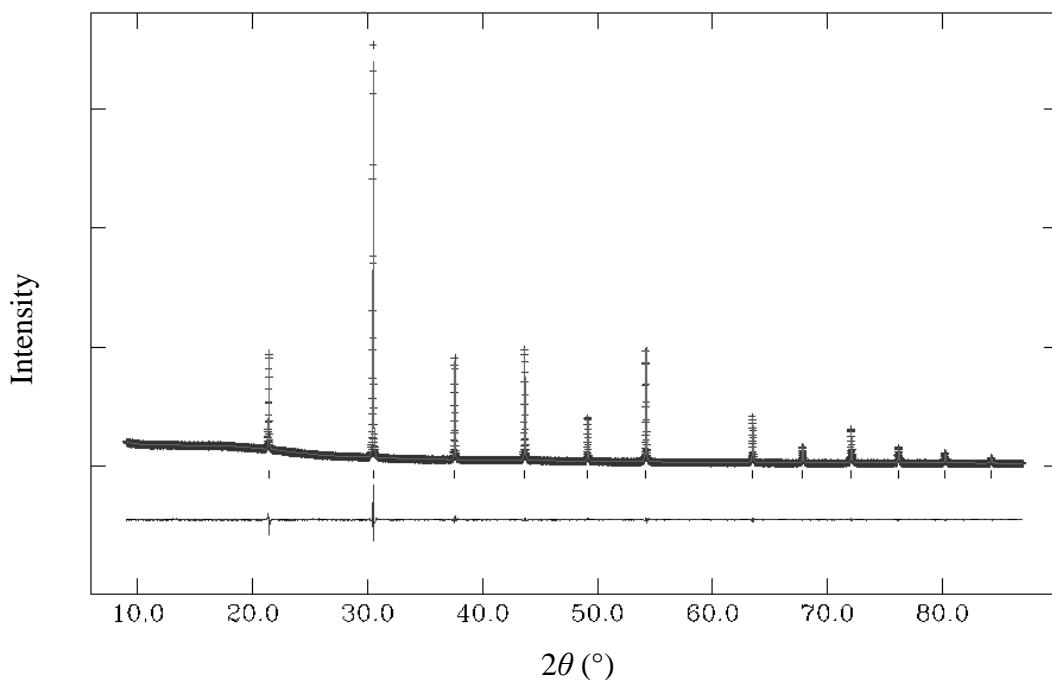


Table 2. Refined crystal structure of  $\text{Ba}_2\text{Sc}_{1.5}\text{P}_{0.5}\text{O}_{5.5}$  using cubic  $Pm\bar{3}m$  (221) space group using room temperature X-ray diffraction data.

		$a$ (Å)	$R_{wp}$	$R_p$	$\chi^2$	
		4.1404 (1)	4.00	2.71	2.44	
		$x$	$y$	$z$	Fractional occupancy	
					$U_{iso}$ (Å <sup>2</sup> x 100)	
Ba	1(b)	$\frac{1}{2}$	$\frac{1}{2}$	$\frac{1}{2}$	1.000	1.88 (1)
Sc	1(a)	0	0	0	0.748 (7)	2.59 (5)
P	1(a)	0	0	0	0.252 (7)	2.59 (5)
O	3(d)	0	0	$\frac{1}{2}$	0.917 (4)	3.9 (1)

Fig. 4 Observed (cross), calculated (line), reflection positions and difference plots (observed – calculated) of  $\text{Ba}_2\text{Sc}_{1.4}\text{Si}_{0.6}\text{O}_{5.3}$  from the Rietveld refinement for room temperature X-ray diffraction data.

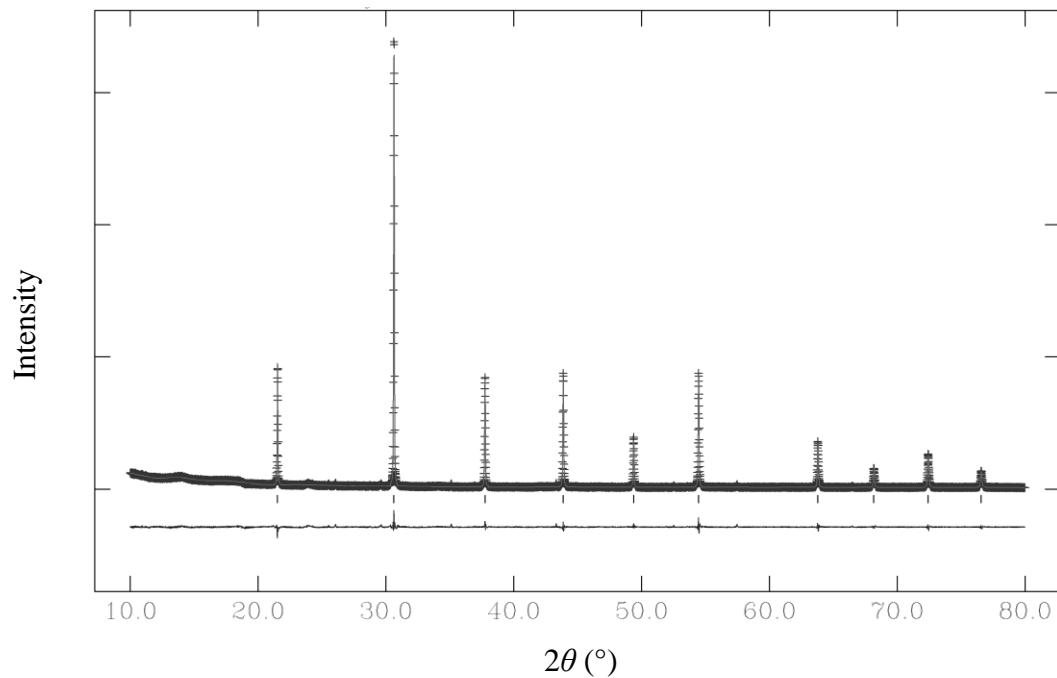


Table 3. Refined crystal structure of  $\text{Ba}_2\text{Sc}_{1.4}\text{Si}_{0.6}\text{O}_{5.3}$  using cubic  $Pm3m$  (221) space group using room temperature X-ray diffraction data.

		$a$ (Å)	$R_{wp}$	$R_p$	$\chi^2$	
		4.1225 (1)	8.72	6.07	2.81	
		$x$	$y$	$z$	Fractional occupancy	
					$U_{iso}$ (Å <sup>2</sup> x 100)	
Ba	1(b)	$\frac{1}{2}$	$\frac{1}{2}$	$\frac{1}{2}$	1.000	1.69 (2)
Sc	1(a)	0	0	0	0.739 (8)	3.12 (7)
Si	1(a)	0	0	0	0.261 (8)	3.12 (7)
O	3(d)	0	0	$\frac{1}{2}$	0.874 (5)	3.6 (1)